

MITSUBISHI LSTTLs  
**M74LS138P**

**3-LINE TO 8-LINE DECODER/DEMULTIPLEXER**

**DESCRIPTION**

The M74LS138P is a semiconductor integrated circuit consisting of a 3-bit binary-octal decoder/demultiplexer with enable inputs.

**FEATURES**

- 3 classes of enable inputs
- 4 to 16 decoder/demultiplexer functions are provided without use of external components.
- Wide operating temperature range ( $T_a = -20 \sim +75^\circ\text{C}$ )

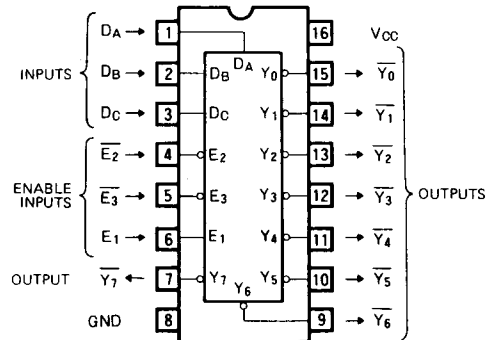
**APPLICATION**

General purpose, for use in industrial and consumer equipment.

**FUNCTIONAL DESCRIPTION**

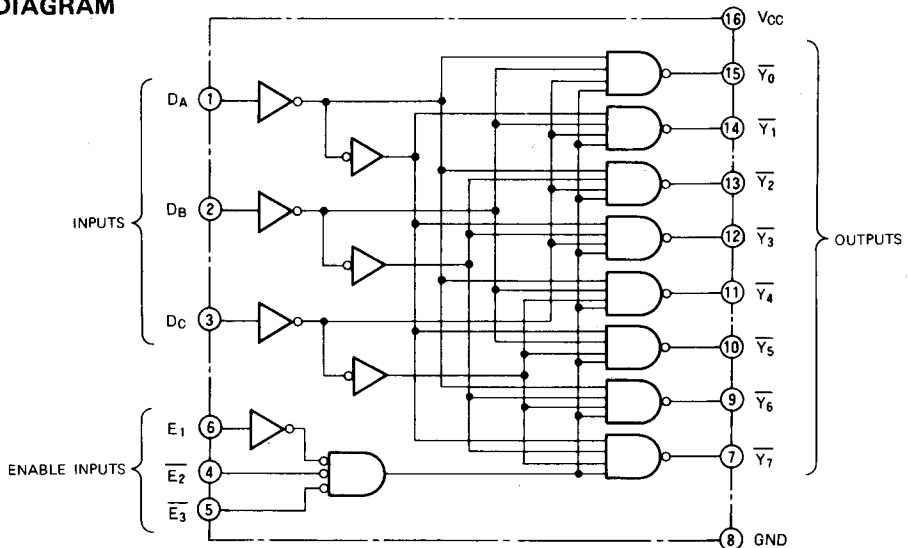
For use as a decoder, specify inputs  $D_A$ ,  $D_B$ , and  $D_C$  in 3-bit binary code. In the case of decoding function, the  $E_1$  is kept in high state while  $\overline{E_2}$  and  $\overline{E_3}$  are kept low. If  $E_1$ ,  $\overline{E_2}$  and  $\overline{E_3}$  are not in these conditions, all the outputs become high, irrespective of the status of  $D_A \sim D_C$ . For use as a demultiplexer,  $\overline{E_1}$ ,  $\overline{E_2}$  and  $E_3$  are used as data inputs and  $D_A$ ,  $D_B$ , and  $D_C$  as selection inputs. This forms a 1-line to 8-line demultiplexer.

**PIN CONFIGURATION (TOP VIEW)**



Outline 16P4

**BLOCK DIAGRAM**



3-LINE TO 8-LINE DECODER/DEMULTIPLEXER

FUNCTION TABLE (Note 1)

E <sub>1</sub>	$\overline{E}_X$	D <sub>C</sub>	D <sub>B</sub>	D <sub>A</sub>	$\overline{Y}_0$	$\overline{Y}_1$	$\overline{Y}_2$	$\overline{Y}_3$	$\overline{Y}_4$	$\overline{Y}_5$	$\overline{Y}_6$	$\overline{Y}_7$
X	H	X	X	X	H	H	H	H	H	H	H	H
L	X	X	X	X	H	H	H	H	H	H	H	H
H	L	L	L	L	L	H	H	H	H	H	H	H
H	L	L	L	H	H	L	H	H	H	H	H	H
H	L	L	H	L	H	H	L	H	H	H	H	H
H	L	L	H	H	H	H	H	L	H	H	H	H
H	L	H	L	L	H	H	H	H	L	H	H	H
H	L	H	L	H	H	H	H	H	H	L	H	H
H	L	H	H	L	H	H	H	H	H	H	L	H
H	L	H	H	H	H	H	H	H	H	H	H	L

Note 1:  $\overline{E}_X = \overline{E}_2 + \overline{E}_3$   
X : irrelevant

ABSOLUTE MAXIMUM RATINGS (T<sub>a</sub> = -20 ~ +75°C, unless otherwise noted)

Symbol	Parameter	Conditions	Limits	Unit
V <sub>CC</sub>	Supply voltage		-0.5 ~ +7	V
V <sub>I</sub>	Input voltage		-0.5 ~ +15	V
V <sub>O</sub>	Output voltage	High-level state	-0.5 ~ V <sub>CC</sub>	V
T <sub>opr</sub>	Operating free-air ambient temperature range		-20 ~ +75	°C
T <sub>stg</sub>	Storage temperature range		-65 ~ +150	°C

RECOMMENDED OPERATING CONDITIONS (T<sub>a</sub> = -20 ~ +75°C, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min	Typ	Max	
V <sub>CC</sub>	Supply voltage	4.75	5	5.25	V
I <sub>OH</sub>	High-level output current				μA
	V <sub>OH</sub> ≥ 2.7V	0		-400	
I <sub>OL</sub>	Low-level output current				mA
	V <sub>OL</sub> ≤ 0.4V	0		4	
	V <sub>OL</sub> ≤ 0.5V	0		8	

ELECTRICAL CHARACTERISTICS (T<sub>a</sub> = -20 ~ +75°C, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ*	Max	
V <sub>IH</sub>	High-level input voltage		2			V
V <sub>IL</sub>	Low-level input voltage				0.8	V
V <sub>IC</sub>	Input clamp voltage	V <sub>CC</sub> = 4.75V, I <sub>IC</sub> = -18mA			-1.5	V
V <sub>OH</sub>	High-level output voltage	V <sub>CC</sub> = 4.75V, V <sub>I</sub> = 0.8V V <sub>I</sub> = 2V, I <sub>OH</sub> = -400μA	2.7	3.4		V
V <sub>OL</sub>	Low-level output voltage	V <sub>CC</sub> = 4.75V		0.25	0.4	V
		V <sub>I</sub> = 0.8V, V <sub>I</sub> = 2V		0.35	0.5	V
I <sub>IH</sub>	High-level input current	V <sub>CC</sub> = 5.25V, V <sub>I</sub> = 2.7V			20	μA
		V <sub>CC</sub> = 5.25V, V <sub>I</sub> = 10V			0.1	mA
I <sub>IL</sub>	Low-level input current	V <sub>CC</sub> = 5.25V, V <sub>I</sub> = 0.4V			-0.4	mA
I <sub>OS</sub>	Short-circuit output current (Note 2)	V <sub>CC</sub> = 5.25V, V <sub>O</sub> = 0V	-20		-100	mA
I <sub>CC</sub>	Supply current	V <sub>CC</sub> = 5.25V (Note 3)		6.3	10	mA

\* : All typical values are at V<sub>CC</sub> = 5V, T<sub>a</sub> = 25°C.

Note 2: All measurements should be done quickly, and not more than one output should be shorted at a time.

Note 3: I<sub>CC</sub> is measured with all output off-state.

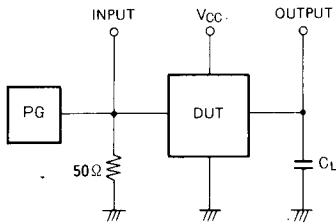
**3-LINE TO 8-LINE DECODER/DEMULTIPLEXER**

**SWITCHING CHARACTERISTICS** ( $V_{CC}=5V$ ,  $T_a=25^\circ C$ , unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
$t_{PLH}$	Low-to-high-level, high-to-low-level output propagation time, from inputs $D_A, D_B, D_C$ to output $\bar{Y}_0-\bar{Y}_7$	delay gate stages 2	9	12	20	ns
$t_{PHL}$						
$t_{PLH}$	Low-to-high-level, high-to-low-level output propagation time, from inputs $E_2, E_3$ to outputs $\bar{Y}_0-\bar{Y}_7$	delay gate stages 3	16	14	27	ns
$t_{PHL}$						
$t_{PLH}$	Low-to-high-level, high-to-low-level output propagation time, from input $E_1$ to outputs $\bar{Y}_0-\bar{Y}_7$	delay gate stages 2	10	15	18	ns
$t_{PHL}$						
$t_{PLH}$	Low-to-high-level, high-to-low-level output propagation time, from input $E_1$ to outputs $\bar{Y}_0-\bar{Y}_7$	delay gate stages 3	8	15	26	ns
$t_{PHL}$						

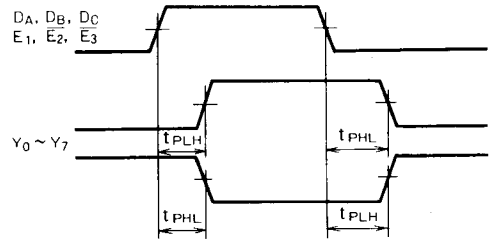
$C_L = 15 \text{ pF (Note 4)}$

Note 4: Measurement circuit



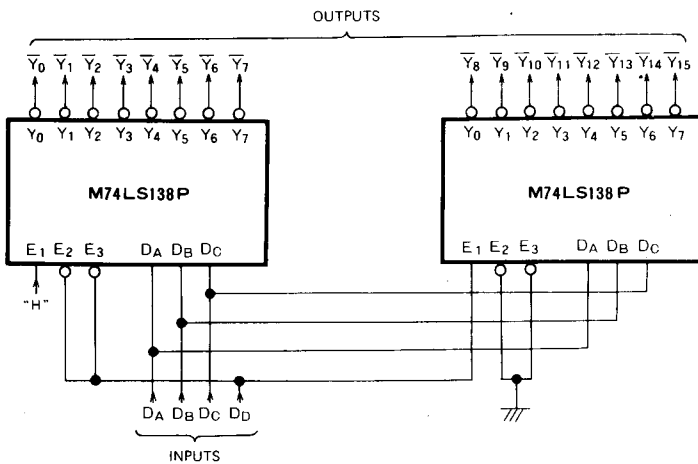
- (1) The pulse generator (PG) has the following characteristics:  
 PRR = 1MHz,  $t_r = 6\text{ns}$ ,  $t_f = 6\text{ns}$ ,  $t_w = 500\text{ns}$ ,  
 $V_P = 3V_{pp}$ ,  $Z_0 = 50\Omega$
- (2)  $C_L$  includes probe and jig capacitance.

**TIMING DIAGRAM (Reference level = 1.3V)**



**APPLICATION EXAMPLE**

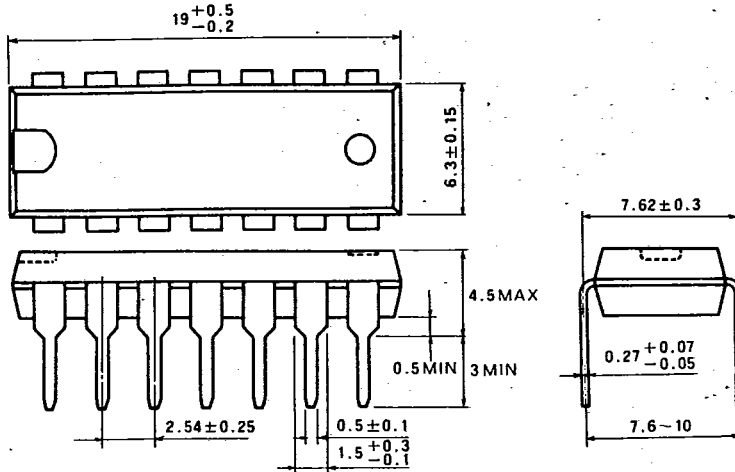
**4-line to 16-line decoder/demultiplexer**



T-90-20

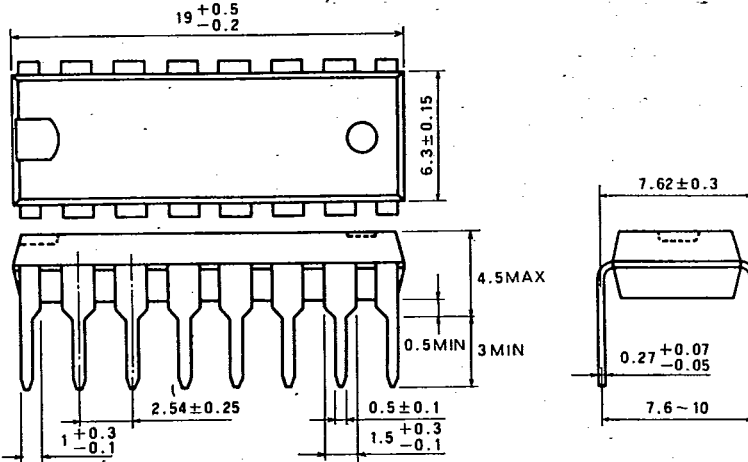
**TYPE 14P4 14-PIN MOLDED PLASTIC DIL**

Dimension in mm



**TYPE 16P4 16-PIN MOLDED PLASTIC DIL**

Dimension in mm



**TYPE 20P4 20-PIN MOLDED PLASTIC DIL**

Dimension in mm

